

Notice of References Cited

Application/Control No.

10/560,951

Applicant(s)/Patent Under
Reexamination
NIWA ET AL.

Examiner

RACHEL KAHN

Art Unit

1796

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP 10151714 A	06-1998	Japan	Sugiura et al.	
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NON-PATENT DOCUMENTS

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